

Impact of the semiconductor on hexagonal-BN structure for power-supply on chip applications

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Abstract

This paper evaluates the semiconductor on hexagonal-BN (h-BN) structure for power-supply on chip applications based on numerical simulations. Hexagonal-BN is used as an insulator of semiconductor-on-insulator (SOI) structure. Hexagonal-BN based SOI structure with through-silicon-via(TSV) shows higher heat dissipation performance without degrading electrical characteristics compared with the conventional SOI structure.

1. Introduction

Recently, power supply on chip (power-SoC), which integrates Si-LSI, power device and passive devices in one chip, has been attracting attentions because it can realize ultimate miniaturization of power supply[1]. The one of the most promising ways to minimize the size of the power supply is to reduce the volume of the passive components such as inductors and capacitors. To increase the switching frequency is an effective approach to do this. The semiconductor on insulator (SOI) technology is the one of the promising candidates for realizing power-SoC because this technology is suitable for high frequency switching, that is resulting from its smaller parasitic capacitance[2]. However, the conventional SOI structure has a problem of self-heating because of low thermal conductivity of SiO₂. Semiconductor-on-Diamond (SOD) structure, which uses thin diamond film as an insulator, has been proposed because the diamond have higher thermal conductivity than SiO₂[3,4]. But it was only about half of exhaust heat effect which is expected from the thermal conductivity of the nano-crystalline diamond[5]. The nano-crystalline diamond has a surface roughness of several nanometers and this film cannot cover the surface of the heat source(in this case Si shown in Figs. 1) and these prevents the heat transfer from heating element to nano-crystalline diamond(Figs.1). This result reveals that higher thermal conductivity and atomically flat surface are required to obtain higher heat exhaust performance. In such situations, hexagonal-BN(h-BN) is attractive for the buried insulator

layer of SOI because it has higher thermal conductivity with atomically flat surface (Ra of h-BN < 0.25 nm)[6,7]. It has not been clarified the impact of the semiconductor on h-BN structure for power supply on chip applications.

In this paper, we explore impact of the semiconductor on h-BN structure for thermal property and device performance based on numerical simulations with comparing SOI structure. In addition, we also discuss the impact of the through silicon via(TSV) for heat dissipation.

2. Device structure

The schematic cross sections of the SOI and the TSV inserted SOI structures used in the simulations are shown in Figs.2 (a), (b). The materials constants of used in the simulations are listed in Table 1. Also the thermal conductivity of the materials is listed in Table 2.

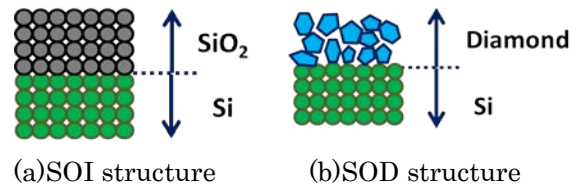


Fig.1 Cross sections of (a)SOI and (b)SOD.

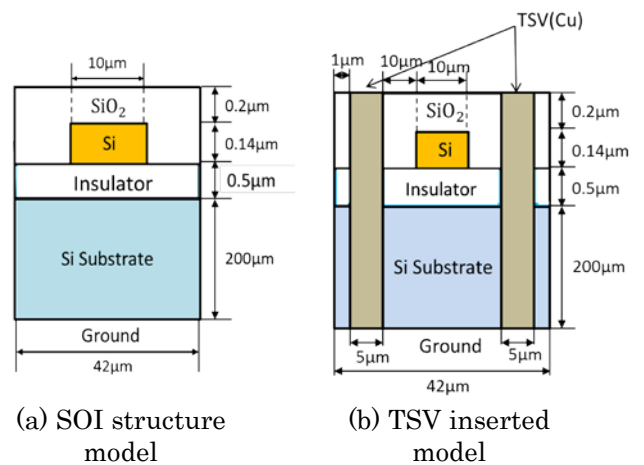


Fig.2 Schematic cross section of the SOI structure used in simulations.

